5/ IDS E. VSILID 10-30-0



Docket No.: MUH-11671

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

STEPHAN APPEN ET AL.

Filed

Concurrently herewith

Title

APPARATUS FOR THE AUTOMATED TESTING, CALIBRATION

AND CHARACTERIZATION OF TEST ADAPTERS

INFORMATION DISCLOSURE STATEMENT

Hon. Commissioner of Patents and Trademarks, Washington, D.C. 20231

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

- U. S. Patent 4,471,298 (Frohlich), dated September 11, 1984;
- U. S. Patent 4,904,934 (Nishihashi et al.), dated February 27, 1990;

International Patent Application PCT/GB98/03262 (Vinson et al.), dated May 14, 1999;

U. K. Patent Application GB 2 240 435 (Barker), dated July 31, 1991;

German Published, Non-Prosecuted Patent Application DE 44 41 347 A1 (Fritzsche), dated May 30, 1996, pertains to an adapting device for the testing of printed circuits.

If no translation of pertinent portions of any foreign language patents or publications mentioned above is included with the aforementioned copies of those applications, patents and/or publications, it is because no existing translation is readily available to the applicant.

Respectfully submitted,

Før Applicants

RALPH E. LOCHER REG. NO. 41,947

Date: August 16, 2001

Lerner and Greenberg, P.A. Post Office Box 2480

Hollywood, FL 33022-2480

Tel: (954) 925-1100 Fax: (954) 925-1101

/vs

١